

EDITOR'S CORNER

The 14th International Workshop on Rapid Methods and Automation in Microbiology, July 8 to July 15, 1994 at Kansas State University, Manhattan, KS.

It is difficult for me to realize that I am now working hard on the 14th workshop in this long and successful series. It seemed like yesterday that I organized the first workshop back in 1981! It was so tiring for me in that workshop that I said I would not do it again — but the 2nd workshop came along and then the 3rd and then the 10th anniversary in 1990 and now the 14th! I will be planning a gala 15th anniversary for 1995.

The workshop truly is an international workshop and the interactions have been great both scientifically and socially. It has been indeed a "Summer camp" for applied microbiologists the world over.

In recent years we have included a one year subscription of the **Journal of Rapid Methods and Automation in Microbiology** as part of the registration fee. We hope that the participants will continue to subscribe to this journal in subsequent years, and when appropriate we also welcome scientists to submit papers for inclusion in the Journal. The second volume, with four issues, is about to be done and now we are working on the third volume.

Rapid Methods and Automation in Microbiology is dynamic — it is a real great pleasure for me to observe its development from the very beginning since 1973.

The program for the 1994 workshop is listed on a separate page. We will again include all the most advanced technologies in the field in the "Hands-on" workshop. Usually the workshop will be filling up in the middle of May. So please send in registrations as early as possible! Also, the deadline for application for graduate student fellowships competition is on April 1, 1994. Please contact the editor (Daniel Y.C. Fung, Telephone 913-532-5654, FAX 913-532-5681) for details on that program. I expect again a very successful workshop, thanks to the support of colleagues in the field and readers of this journal.

DANIEL Y.C. FUNG